reflect the corrected language described in both our Prelim Analysis Memo at 7 and petitioners' February 14, 2005. Ministerial Error Allegation at 4 in the U.S. sales program, which can be found in the analysis memorandum for the amended final results. See Memorandum to the File through Abdelali Elouaradia, Program Manager, Office 7, Analysis for ThyssenKrupp Acciai Speciali Terni S.p.A. (TKAST) for the Amended Final Results of the Antidumping Duty Administrative Review of Stainless Steel Sheet and Strip in Coils from Italy, dated March 9, 2005 (Amended Final Analysis Memo). As a result of the correction of a ministerial error in the Final Results. the revised weight-averaged dumping margin is as follows:

Manufacturer/exporter	Weighted-aver- age margin (percent)
ThyssenKrupp Acciai Speciali Terni S.p.A.	23.73

See Amended Final Analysis Memo at Attachment 4 for programming details.

With respect to TKAST, the Department will issue appropriate assessment instructions to U.S. Customs and Border Protection (CBP) within 15 days of publication of the amended final results of review. Accordingly, the Department will determine, and CBP will assess, antidumping duties on all entries of subject merchandise from TKAST during the period July 1, 2002, through June 30, 2003, in accordance with these amended final results. The revised cash deposit rate for TKAST shown above is effective on all shipments of the subject merchandise entered, or withdrawn from warehouse, for consumption on or after the date of publication of this notice, and will remain in effect until publication of the final results of the next administrative review.

Consequently, we are issuing and publishing these amended final results and notice in accordance with sections 751(a)(1), 751(h), and 777(i) of the Act, and 19 CFR 351.224(f).

Dated: March 11, 2005.

# Barbara E. Tillman,

Acting Assistant Secretary for Import Administration.

[FR Doc. E5-1167 Filed 3-16-05; 8:45 am]

# BILLING CODE 3510-DS-P

### **DEPARTMENT OF COMMERCE**

#### **International Trade Administration**

# California Department of Food and Agriculture, et al.; Notice of Consolidated Decision on Applications for Duty-Free Entry of Electron Microscopes

This is a decision consolidated pursuant to section 6(c) of the Educational, Scientific, and Cultural Materials Importation Act of 1966 (Pub. L. 89–651, 80 Stat. 897; 15 CFR part 301). Related records can be viewed between 8:30 a.m. and 5 p.m. in Suite 4100W, Franklin Court Building, U.S. Department of Commerce, 1099 14th Street, NW., Washington, DC.

Docket Number: 05–001.

Applicant: California Department of Food and Agriculture, Sacramento, CA 95832.

*Instrument:* Electron Microscope, Model H–7500–1 TEM.

Manufacturer: Hitachi High-Technologies Corp., Japan.

Intended Use: See notice at 70 FR 6838, February 9, 2005. Order Date: March 29, 2004.

Docket Number: 05–003. Applicant: Brigham Young University, Provo, UT 84602.

Instrument: Electron Microscope, Model Technai G<sup>2</sup> F20 U-TWIN STEM.

*Manufacturer:* FEI Company, The Netherlands.

*Intended Use:* See notice at 70 FR 9046, February 24, 2005.

Order Date: March 28, 2003.

Docket Number: 05-004.

Applicant: University of Delaware, Newark, DE 19716.

*Instrument:* Electron Microscope, Model Technai G<sup>2</sup> 12 Twin.

Manufacturer: FEI Company, Czech Republic.

*Întended Use:* See notice at 70 FR 9046, February 24, 2005.

Order Date: May 6, 2004.

Docket Number: 05-006.

*Applicant:* University of Pittsburgh, Pittsburgh, PA 15261.

*Instrument:* Electron Microscope, Model JEM–1011.

Manufacturer: JEOL Ltd., Japan. Intended Use: See notice at 70 FR 10357, March 3, 2005.

Order Date: March 4, 1904.

Docket Number: 05–007.

Applicant: Clemson University, Clemson, SC 29634.

*Instrument:* Electron Microscope, Model H–7600.

*Manufacturer:* Hitachi High-Technologies Corp., Japan.

Intended Use: See notice at 70 FR 10357, March 3, 2005.

Order Date: May 4, 2004.

Docket Number: 05-008.

Applicant: Rice University, Houston, TX 77005.

*Instrument:* Electron Microscope, Model JEM–1230.

Manufacturer: JEOL Ltd., Japan. Intended Use: See notice at 70 FR 10357, March 3, 2005.

Order Date: June 25, 2004.

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Docket Number: 05-009.

*Applicant:* Rice University, Houston, TX 77005.

*Instrument:* Electron Microscope, Model JEM–2100F.

Manufacturer: JEOL Ltd., Japan. Intended Use: See notice at 70 FR 10357, March 3,2005.

Order Date: June 25, 2004.

Docket Number: 05-010.

*Applicant:* Tuskegee University, Tuskegee, AL 36008.

Instrument: Electron Microscope, Model JEM–2010.

Manufacturer: JEOL Ltd., Japan. Intended Use: See notice at 70 FR

10357, March 3, 2005. Order Date: May 19, 2004.

Comments: None received.

Decision: Approved. No instrument of equivalent scientific value to the foreign instrument, for such purposes as these instruments are intended to be used, was being manufactured in the United States at the time the instruments were ordered.

Reasons: Each foreign instrument is a conventional transmission electron microscope (CTEM) and is intended for research or scientific educational uses requiring a CTEM. We know of no CTEM, or any other instrument suited to these purposes, which was being manufactured in the United States either at the time of order of each instrument OR at the time of receipt of application by U.S. Customs and Border Protection.

# Gerald A. Zerdy,

Program Manager, Statutory Import Programs Staff.

[FR Doc. E5–1171 Filed 3–16–05; 8:45 am]
BILLING CODE 3510–P

# **DEPARTMENT OF COMMERCE**

### **International Trade Administration**

# Cornell University; Notice of Decision on Application for Duty-Free Entry of Scientific Instrument

This decision is made pursuant to section 6(c) of the Educational, Scientific, and Cultural Materials Importation Act of 1966 (Pub. L. 89–651, 80 Stat. 897; 15 CFR part 301).

<sup>&</sup>lt;sup>2</sup> The weighted-average dumping margin previously calculated for TKAST was 3.72 percent. See Final Results, 70 FR at 7474.

Related records can be viewed between 8:30 a.m. and 5 p.m. in Suite 4100W, U.S. Department of Commerce, Franklin Court Building, 1099 14th Street, NW., Washington, DC.

Docket Number: 05-002.

Applicant: Cornell University, Ithaca, NY 14853.

Instrument: KB Mirror System. Manufacturer: Khozu Precision Co., Ltd., Japan.

Intended Use: See notice at 70 FR February 7, 2005.

Comments: None received.

Decision: Approved. No apparatus of equivalent scientific value to the foreign apparatus, for such purposes as it is intended to be used, is being manufactured in the United States.

*Reason:* This is a compatible accessory for an existing instrument purchased for the use of the applicant. The accessory is pertinent to the intended uses and we know of no domestic accessory which can be readily adapted for use with the existing instrument.

### Gerald A. Zerdy,

Program Manager, Statutory Import Programs

[FR Doc. E5-1173 Filed 3-16-05; 8:45 am] BILLING CODE 3510-DS-P

# **DEPARTMENT OF COMMERCE**

## **International Trade Administration**

### Applications for Duty-Free Entry of **Scientific Instruments**

Pursuant to Section 6(c) of the Educational, Scientific and Cultural Materials Importation Act of 1966 (Pub. L. 89-651; 80 Stat. 897; 15 CFR part 301), we invite comments on the question of whether instruments of equivalent scientific value, for the purposes for which the instruments shown below are intended to be used, are being manufactured in the United States.

Comments must comply with 15 CFR 301.5(a)(3) and (4) of the regulations and be filed within 20 days with the Statutory Import Programs Staff, U.S. Department of Commerce, Washington, DC 20230. Applications may be examined between 8:30 a.m. and 5 p.m. in Suite 4100W, U.S. Department of Commerce, Franklin Court Building, 1099 14th Street, NW., Washington, DC.

Docket Number: 00-011.

Applicant: Johns Hopkins University, School of Medicine, Microscope Facility, 725 N. Wolfe Street, Physiology Building, Room G-4, Baltimore, MD 21205.

*Instrument:* Electron microscope, Model H-7600-I.

Manufacturer: Hitachi High-Technologies Corporation, Japan.

*Intended Use:* The instrument is intended to be used to investigate:

- (1) The mechanical properties of intermediate filaments composed of keratin;
- (2) The structure and replication mechanism of kinoplast DNA;
- (3) The basis of bacterial gliding motility by means of slime expulsion in certain prokaryotic cells;
- (4) The mechanism of membrane protein delivery to the plasma membrane in mammalian cells;
- (5) Identification of novel genes that play critical roles in the development of the retina.

Application accepted by Commissioner of Customs: February 25, 2005.

Docket Number: 05-012.

Applicant: University of Chicago, 933 East 56th Street, Chicago, IL 60637.

Instrument: Pattern Selection Trigger. Manufacturer: Hytec Electronics, Ltd., United Kingdom.

Intended Use: The instrument is intended to be used, in conjunction with a digital computer system, for a telescope to study high-energy gammarays of astronomical origin.

Application accepted by Commissioner of Customs: February 28,

Docket Number: 05-013.

Applicant: National Institute of Standards and Technology.

Instrument: Focused Ion Beam Field **Emission Scanning Electron** Microscope, Model Nova 600 NanoLab.

Manufacturer: FEI Company, The Netherlands.

Intended Use: The instrument is intended to allow complex, chemically heterogeneous materials to be both synthesized using materials deposition from gas injection systems, and to be sectioned and ion milled using a Gallium ion beam for removal of material for study of the gross morphology, crystal structure and microstructure, chemical composition, electronic structure, and transport properties of materials to be measured on nanometer length scales. The phenomena of electron scattering, x-ray generation, beam transport, absorption and internal fluoresence will be studied to perform quantitative analyses of nanoscale materials for numerous ongoing research projects.

Application accepted by Commissioner of Customs: March 2, 2005.

### Gerald A. Zerdy,

Program Manager, Statutory Import Programs Staff.

[FR Doc. E5-1172 Filed 3-16-05; 8:45 am] BILLING CODE 3510-DS-P

### **DEPARTMENT OF COMMERCE**

## Submission for OMB Review; **Comment Request**

The Department of Commerce has submitted to the Office of Management and Budget (OMB) for clearance the following proposal for collection of information under the provisions of the Paperwork Reduction Act (44 U.S.C. Chapter 35).

Agency: National Oceanic and Atmospheric Administration (NOAA).

Title: Southwest Region Permit Family of Forms—Pacific. Form Number(s): None.

OMB Approval Number: 0648-0490. Type of Request: Regular submission. Burden Hours: 85.

Number of Respondents: 200. Average Hours per Response: 23 minutes.

Needs and Uses: The permits are required for persons to participate in federally-managed fisheries in the western Pacific region and off the U.S. West Coast. The Western Pacific Fishery Management Council has recommended the National Marine Fisheries Service's (NMFS) approval and implementation of Amendment 11 to the Fishery Management Plan for the Pelagic Fisheries of the Western Pacific Region. Amendment 11 would establish a limited access permit program for the American Samoa-based pelagic longline fishery which necessitates a revised collection of information. The program requires information from potential initial participants and subsequent new entrants (via permit transfers) in the fishery. NMFS will use the information to determine who is eligible for issuance of American Samoa longline limited access permits. The fishermen will be required to use appropriate permit application forms/supplementary information sheets provided by NMFS.

Affected Public: Business or other forprofit organizations; Individuals or households.

Frequency: Variable.

Respondent's Obligation: Mandatory. OMB Desk Officer: David Rostker, (202) 395-3897.

Copies of the above information collection proposal can be obtained by calling or writing Diana Hynek,